

# **FCC TEST REPORT**

Product Name: Mobile Phone

Trade Mark: N/A

Model No.: CRUSH X565

FCC ID: 2AIMEX565

Report Number: 180709006EMC-1

Test Standards: FCC 47 CFR Part 15 Subpart B

Test Result: PASS

Date of Issue: July 26, 2018

#### Prepared for:

# SMT TELECOMM HK LIMITED Unit C 8/F CHARMHILL CTR 50 HILLWOOD RD TST KL, Kowloon, Hong Kong

#### Prepared by:

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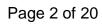
Report No.: 180709006EMC-1

Date:

Suly 26, 2018

\*Certified

Approved by:





**Version** 

Version No.	Date	Description
V1.0 July 26, 2018 Original		Original





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# 1. GENERAL INFORMATION

# 1.1 CLIENT INFORMATION

Applicant: SMT TELECOMM HK LIMITED		
Address of Applicant:	Unit C 8/F CHARMHILL CTR 50 HILLWOOD RD TST KL, Kowloon, Hong Kong	
Manufacturer:	SMT TELECOMM HK LIMITED	
Address of Manufacturer:	Unit C 8/F CHARMHILL CTR 50 HILLWOOD RD TST KL, Kowloon, Hong Kong	

# 1.2 EUT INFORMATION

1.2.1 General Description of EUT

Product Name:	Mobile Phone	
Model No.:	CRUSH X565	
Add. Model No.:	N/A	
Trade Mark:	N/A	
DUT Stage:	Identical Prototype	
Power Supply:	100-240V~50/60 Hz or/and 3.8 V Battery	
Classification of digital devices:	Class B	
Highest Internal Frequency:	2.48 GHz	
Software Version:	SMT_SN_X565_V2984_FINAL	
Hardware Version:	W56A_V3	
Sample Received Date:	July 10, 2018	
Sample Tested Date:	July 10, 2018 to July 26, 2018	

1.2.2 Description of Accessories

Adapter Adapter					
Model No.:	PCX565				
Input:	100-240 V~50/60 Hz 0.15 A				
Output:	5.0 V == 1000 mA				
AC Cable:	N/A				
DC Cable:	N/A				

Battery					
Model No.:	BPX565				
Battery Type: Lithium-ion Rechargeable Battery					
Rated Voltage:	3.8 Vdc				
Rated Capacity:	2000 mAh				

Cable			
Description:	Description: USB Micro-B Plug Cable		
Cable Type: Shielded without ferrite			
Length:	Length: 1.1 Meter		



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#### 1.3 DESCRIPTION OF SUPPORT UNITS

The EUT has been tested with associated equipment below.

1) Support Equipment

Description	Manufacturer	Model No.	Serial Number	Supplied by
Notebook	Lenovo	E450	SL10G10780	UnionTrust
mouse	DELL	MS111	CN-011D3V-738	UnionTrust
USB Disk	Kingston	DTSE9	N/A	UnionTrust
Earphone	BLU	N/A	N/A	UnionTrust

2) Support Cable

Cable No.	Description	Connector	Length	Supplied by
	-	1	-	

#### 1.4 TEST LOCATION

#### Shenzhen UnionTrust Quality and Technology Co., Ltd.

Address: 16/F, Block A, Building 6, Baoneng Science and Technology Park, Qingxiang Road No.1, Longhua

New District, Shenzhen, China 518109 Telephone: +86 (0) 755 2823 0888 Fax: +86 (0) 755 2823 0886

#### 1.5 TEST FACILITY

The test facility is recognized, certified, or accredited by the following organizations:

#### CNAS-Lab Code: L9069

The measuring equipment utilized to perform the tests documented in this report has been calibrated once a year or in accordance with the manufacturer's recommendations, and is traceable under the ISO/IEC/EN 17025 to international or national standards. Equipment has been calibrated by accredited calibration laboratories.

#### IC-Registration No.: 21600-1

The 3m Semi-anechoic chamber of Shenzhen UnionTrust Quality and Technology Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 21600-1.

#### A2LA-Lab Certificate No.: 4312.01

Shenzhen UnionTrust Quality and Technology Co., Ltd. has been accredited by A2LA for technical competence in the field of electrical testing, and proved to be in compliance with ISO/IEC 17025: 2005 General Requirements for the Competence of Testing and Calibration Laboratories and any additional program requirements in the identified field of testing.

#### FCC Accredited Lab.

Designation Number: CN1194

Test Firm Registration Number: 259480

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#### 1.6 DEVIATION FROM STANDARDS

None.

#### 1.7 ABNORMALITIES FROM STANDARD CONDITIONS

None.

#### 1.8 OTHER INFORMATION REQUESTED BY THE CUSTOMER

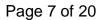
None.

#### 1.9 MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the Product as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at

approximately the 95% confidence level using a coverage factor of k=2.

No.	Item	Measurement Uncertainty		
1	Conducted emission 9KHz-150KHz	±3.8 dB		
2	Conducted emission 150KHz-30MHz	±3.4 dB		
3	Radiated emission 9KHz-30MHz	±4.9 dB		
4	Radiated emission 30MHz-1GHz	±4.7 dB		
5	Radiated emission 1GHz-18GHz	±5.1 dB		
6	Radiated emission 18GHz-26GHz	±5.2 dB		
7	Radiated emission 26GHz-40GHz	±5.2 dB		





2. TEST SUMMARY

FCC 47 CFR Part 15 Subpart B Test Cases						
Test Item	Test Item Test Requirement Test Method Result					
Conducted Emission	FCC 47 CFR Part 15.107	ANSI C63.4-2014	PASS			
Radiated Emission FCC 47 CFR Part 15.109 ANSI C63.4-2014 PASS						

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# 3. EQUIPMENT LIST

	Radiated Emission Test Equipment List							
Used	Equipment	Manufacturer	Model No.	Serial Number	Cal. date (mm dd, yyyy)	Cal. Due date (mm dd, yyyy)		
>	3M Chamber & Accessory Equipment	ETS-LINDGREN	3M	N/A	Dec. 20, 2015	Dec. 19, 2018		
~	Receiver	R&S	ESIB26	100114	Dec. 10, 2017	Dec. 10, 2018		
~	Broadband Antenna	ETS-LINDGREN	3142E	00201566	Dec. 17, 2017	Dec. 17, 2018		
~	Preamplifier	HP	8447F	2805A02960	Dec. 10, 2017	Dec. 10, 2018		
•	Horn Antenna (Pre-amplifier)	ETS-LINDGREN	3117-PA	00201874	May 22, 2018	May 22, 2019		
>	Horn Antenna (Pre-amplifier)	ETS-LINDGREN	3116C-PA	00202652	Dec. 17, 2017	Dec. 17, 2018		
>	Multi device Controller	ETS-LINDGREN	7006-001	00160105	N/A	N/A		
>	Test Software	Audix	e3	Software Version: 9.160323				

Conducted Emission Test Equipment List							
Used	Equipment	Manufacturer	Model No.	Serial Number	Cal. date (mm dd, yyyy)	Cal. Due date (mm dd, yyyy)	
•	Receiver	R&S	ESR7	1316.3003K07 -101181-K3	Dec. 10, 2017	Dec. 10, 2018	
>	Pulse Limiter	R&S	ESH3-Z2	0357.8810.54	Dec. 10, 2017	Dec. 10, 2018	
>	LISN	R&S	ESH2-Z5	860014/024	Dec. 10, 2017	Dec. 10, 2018	
~	Test Software	Audix	e3	Software Version: 9.160323			



### 4. TEST CONFIGURATION

#### 4.1 ENVIRONMENTAL CONDITIONS FOR TESTING

#### 4.1.1 Normal or Extreme Test Conditions

<b>Environment Parameter</b>	Selected Values During Tests				
Test Condition	Ambient				
rest Condition	Temperature (°C)	Voltage (V)	Relative Humidity (%)		
NT/NV	+15 to +35	120V~60 Hz/240V~50 Hz or/and 3.8 V Battery	20 to 75		
Remark:  1) NV: Normal Voltage; NT: Normal Temperature					

#### 4.1.2 Record of Normal Environment

Test Item	Temperature (°C)	Relative Humidity (%)	Pressure (Kpa)	Tested by
Conducted Emission	24.9	52	98.97	Andy Lin
Radiated Emission	24.8	52	99.13	Terence Chen

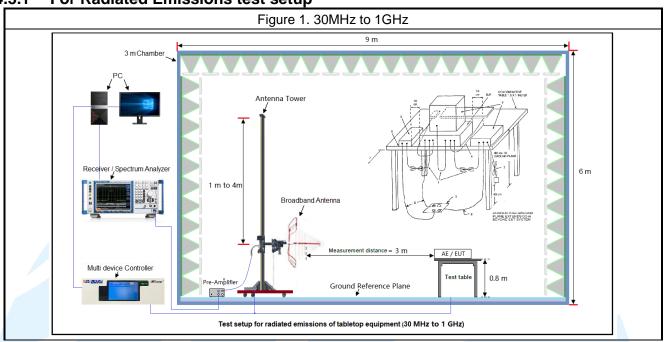
#### **4.2 TEST MODES**

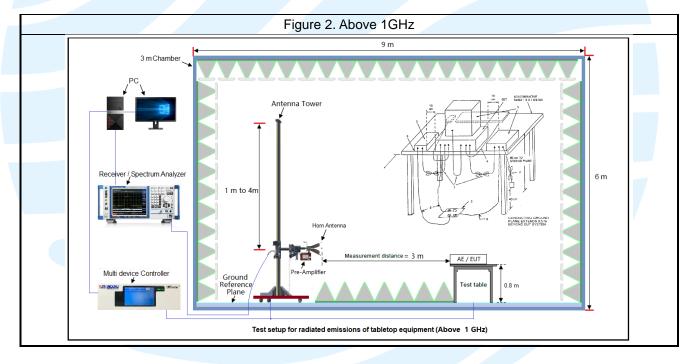
Ξ.		
	Test Item	EMI Test Modes
	Radiated Emission	Mode 1: Charging from 120 Vac + MP4 playing (With TF Card) + Earphone Mode 2: Charging from 120 Vac + Camera (Front) + With TF Card Mode 3: Charging from 120 Vac + Camera (Rear) + With TF Card  Mode 4: Charging from 120 Vac + FM (With Earphone)  Mode 5: Charging from 240 Vac + Worse from mode 1~4  Mode 6: USB Cable (data transfer with notebook) + With TF Card
	Conducted Emission	Mode 1: Charging from 120 Vac + MP4 playing (With TF Card) + Earphone Mode 2: Charging from 120 Vac + Camera (Front) + With TF Card Mode 3: Charging from 120 Vac + Camera (Rear) + With TF Card Mode 4: Charging from 120 Vac + FM (With Earphone)  Mode 5: Charging from 240 Vac + Worse from mode 1~4  Mode 6: USB Cable (data transfer with notebook) + With TF Card



#### **4.3 TEST SETUP**

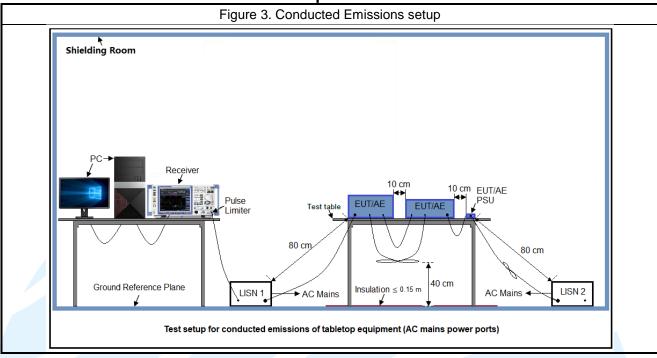
#### 4.3.1 For Radiated Emissions test setup







#### 4.3.2 For Conducted Emissions test setup



#### 4.4 SYSTEM TEST CONFIGURATION

All readings are extrapolated back to the equivalent three meter reading using inverse scaling with distance. Analyzer resolution is 100 kHz or greater for frequencies below 1000MHz. The resolution is 1 MHz or greater for frequencies above 1000MHz. The spurious emissions more than 20 dB below the permissible value are not reported.

Radiated emission measurement were performed from the lowest radio frequency signal generated in the device which is greater than 9 kHz to the tenth harmonic (according to KDB 896810 D02 SDoC FAQ v01r01) of the highest fundamental frequency or to 40 GHz, whichever is lower.



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#### 5. REFERENCE DOCUMENTS FOR TESTING

No.	Identity	Identity Document Title	
1	FCC 47 CFR Part15 Subpart B	Unintentional Radiators	
2	ANSI C63.4-2014	American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz	

# 6. EMC REQUIREMENTS SPECIFICATION

#### 6.1 RADIATED EMISSION

Test Requirement: FCC 47 CFR Part 15.109

Test Method: ANSI C63.4-2014

Receiver Setup:

Frequency: (f)	Dotootor type	Measurement receiver bandwidth		
(MHz)	Detector type	RBW	VBW	
$30 \le f \le 1000$	Quasi Peak	120 kHz	300 kHz	
£>4000	Peak	1 MHz	3 MHz	
f ≥1000	Average	1 MHz	3 MHz	

#### Measured frequency range

Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measurement range (MHz)	
Below 1.705	30.	
1.705-108	1000.	
108-500	2000.	
500-1000	5000.	
Above 1000	5th harmonic of the highest frequency or 40 GHz, whichever is lower.	

#### Limits:

Limits for Class B devices

Fraguency (MHz)	limits at 3m (dBμV/m)			
Frequency (MHz)	QP Detector	PK Detector	AV Detector	
30-88	40.0			
88-216	43.5			
216-960	46.0			
960 to 1000	54.0			
Above 1000		74.0	54.0	

#### Remark:

- 1. The lower limit shall apply at the transition frequencies.
- 2. Emission level  $(dB\mu V/m) = 20 \log Emission level (\mu V/m)$ .
- 3. For frequencies above 1000 MHz, the field strength limits are based on average detector, however, the peak field strength of any emission shall not exceed the maximum permitted average limits, specified above by more than 20 dB under any condition of modulation.

**Test Setup:** Refer to section 4.3.1 for details.

#### **Test Procedures:**

- 1. From 30 MHz to 1GHz test procedure as below:
- 1) The Product was placed on the non-conductive turntable 0.8 m above the ground at a chamber.
- 2) Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 120 kHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied between 1~4 m in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.



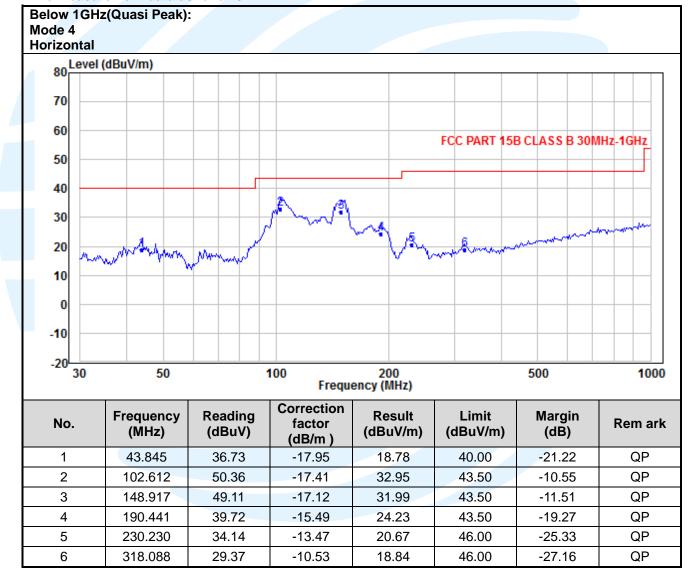
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- 3) For each frequency whose maximum record was higher or close to limit, measure its QP value: vary the antenna's height and rotate the turntable from 0 to 360 degrees to find the height and degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to QP Detector and specified bandwidth with Maximum Hold Mode, and record the maximum value.
- 2. Above 1GHz test procedure as below:
- 1) The Product was placed on the non-conductive turntable 0.8 m above the ground at a chamber.
- 2) Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 1MHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- 3) For each frequency whose maximum record was higher or close to limit, measure its AV value: rotate the turntable from 0 to 360 degrees to find the degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to AV value and specified bandwidth with Maximum Hold Mode, and record the maximum value.

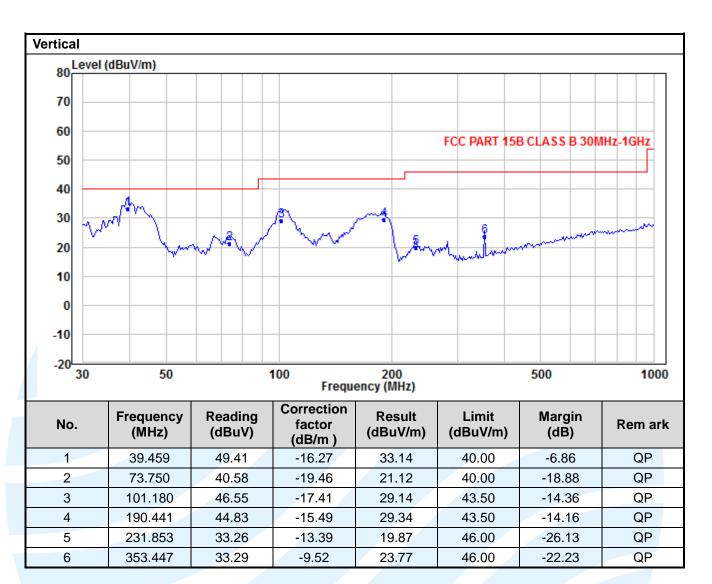
**Equipment Used:** Refer to section 3 for details.

Test Result: Pass

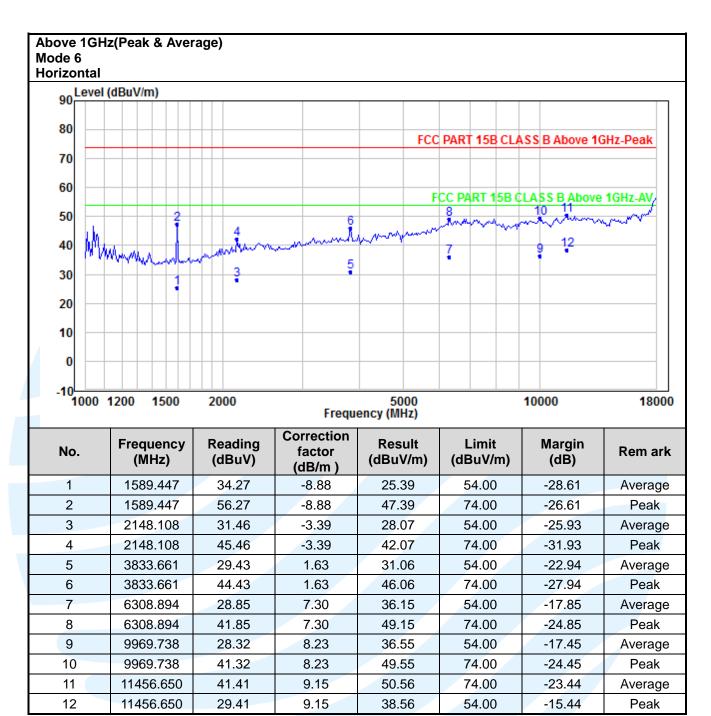
The measurement data as follows:



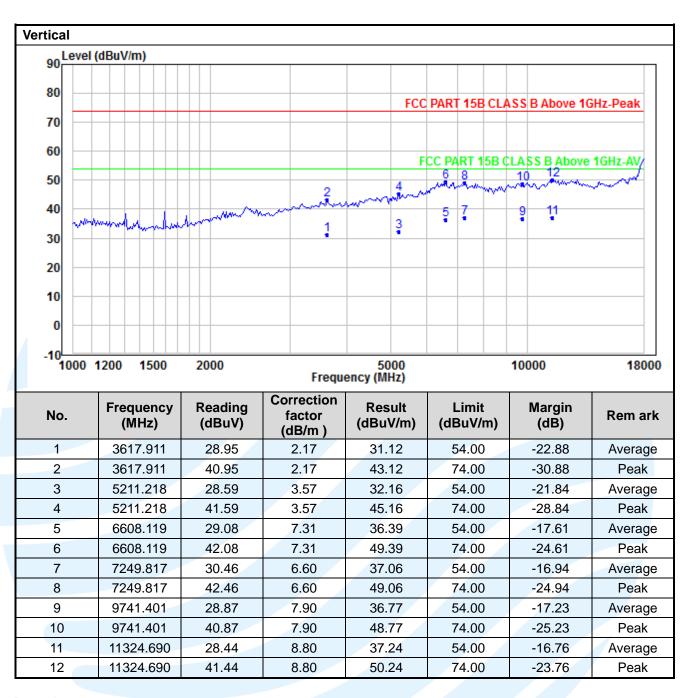












#### Remark:

- 1. All possible modes of operation were investigated. Only the worst case emissions reported.
- 2. Margin = Result Limit
- 3. For above 10 GHz radiated emission, the amplitude of spurious emissions attenuated more than 20 dB below the permissible value is not required to be report.



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#### **6.2 CONDUCTED EMISSION**

Test Requirement: FCC 47 CFR Part 15.107

Test Method: ANSI C63.4-2014

Limits:

Limits for Class B devices

Frequency range	Limits (dB(μV)		
(MHz)	Quasi-peak	Average	
0,15 to 0,50	66 to 56	56 to 46	
0,50 to 5	56	46	
5 to 30	60	50	

#### Remark:

1. The lower limit shall apply at the transition frequencies.

2. The limit decreases linearly with the logarithm of the frequency in the range 0.15 to 0.50 MHz.

**Test Setup:** Refer to section 4.3.2 for details.

#### **Test Procedures:**

1) The Product was placed on a nonconductive table 0.8 m above the horizontal ground reference plane, and 0.4 m from the vertical ground reference plane, and connected to the main through Line Impedance Stability Network (L.I.S.N).

2) The RBW of the receiver was set at 9 kHz in 150 kHz ~ 30MHz with Peak and AVG detector in Max Hold mode. Run the receiver's pre-scan to record the maximum disturbance generated from Product in all power lines in the full band.

For each frequency whose maximum record was higher or close to limit, measure its QP and AVG values and record.

**Equipment Used:** Refer to section 3 for details.

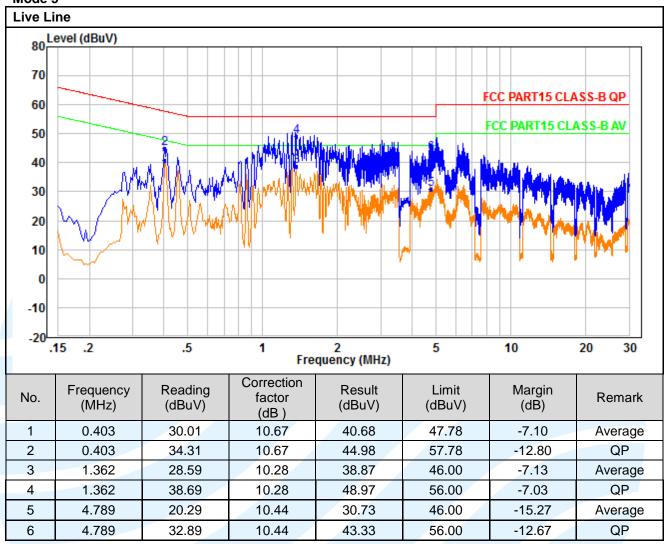
Test Result: Pass



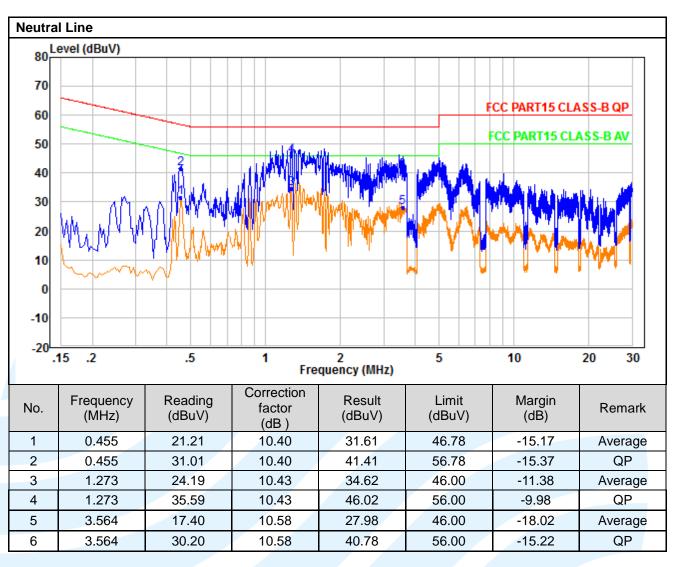
The measurement data as follows:

**Quasi Peak and Average:** 

Mode 5







#### Remark:

1. An initial pre-scan was performed on the Phase and neutral lines with peak detector. Quasi-Peak and Average measurement were performed at the frequencies with maximized peak emission were detected.

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#### **APPENDIX 1 PHOTOS OF TEST SETUP**

See test photos attached in Appendix 1 for the actual connections between Product and support equipment.

## **APPENDIX 2 PHOTOS OF EUT CONSTRUCTIONAL DETAILS**

Refer to Appendix 2 for EUT external and internal photos.

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test report is effect to the sample(s)	ctive only with bo ested. Without w	oth signature and vritten approval	d specialized stam of UnionTrust, this	p. The result(s) s report can't be re	shown in this report re eproduced except in